Applicant(s)/Patent Under Reexamination Application/Control No. 10/684,737 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Rip A. Lee 1713

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-		·	
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2	JP 2000-290431	10-2000	Japan	Yagi et al.	C08L 21/00
	0					
	Р					
	α					
	R					
	S					·
	Т			•		

NON-PATENT DOCUMENTS								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U	JP 2000-290431 (abstract and translation in English)						
	٧							
	W							
	х	J.P. 19 2000						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY regnat are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)